### 捷多邦,专业PCB打样**SN**54**AH©573** 出**SN**74AHC573 OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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- EPIC™ (Enhanced-Performance Implanted CMOS) Process
- Operating Range 2-V to 5.5-V V<sub>CC</sub>
- 3-State Outputs Directly Drive Bus Lines
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

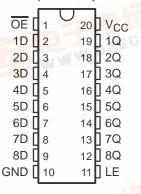
#### description

The 'AHC573 devices are octal transparent D-type latches designed for 2-V to 5.5-V V<sub>CC</sub> operation.

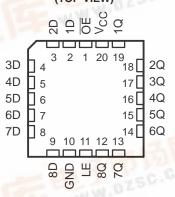
When the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is low, the Q outputs are latched at the logic levels of the D inputs.

A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

SN54AHC573 . . . J OR W PACKAGE SN74AHC573 . . . DB, DGV, DW, N, OR PW PACKAGE (TOP VIEW)



SN54AHC573 . . . FK PACKAGE (TOP VIEW)



OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54AHC573 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74AHC573 is characterized for operation from –40°C to 85°C.

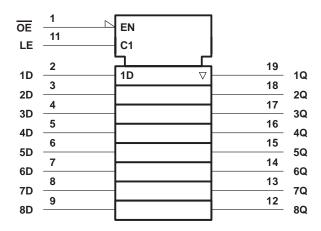
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### FUNCTION TABLE (each latch)

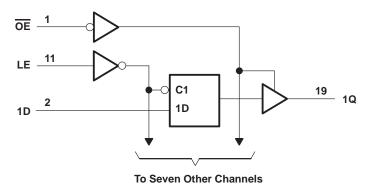
	INPUTS		OUTPUT
OE	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q <sub>0</sub>
Н	X	Χ	Z

### logic symbol†



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)



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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>		0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)		
Output voltage range, VO (see Note 1)		–0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ )		–20 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CO}$	c)	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	·····	±25 mA
Continuous current through V <sub>CC</sub> or GND		
Package thermal impedance, $\theta_{JA}$ (see Note 2)		
,	DGV package	
	DW package	58°C/W
	N package	69°C/W
	PW package	83°C/W
Storage temperature range, T <sub>stq</sub>		–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

#### recommended operating conditions (see Note 3)

			SN54A	SN54AHC573		HC573	UNIT	
			MIN	MAX	MIN	MAX	UNII	
Vcc	Supply voltage		2	5.5	2	5.5	V	
		V <sub>CC</sub> = 2 V	1.5		1.5			
$\vee_{IH}$	High-level input voltage	V <sub>CC</sub> = 3 V	2.1		2.1		V	
		V <sub>CC</sub> = 5.5 V	3.85		3.85			
		V <sub>CC</sub> = 2 V		0.5		0.5		
VIL	Low-level input voltage	V <sub>CC</sub> = 3 V		0.9		0.9	V	
		V <sub>CC</sub> = 5.5 V		1.65		1.65		
٧ı	Input voltage	-	0	5.5	0	5.5	V	
VO	Output voltage		0	Vcc	0	Vcc	V	
		V <sub>CC</sub> = 2 V		-50		-50	μΑ	
ІОН	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$	П	-4		-4	^	
		$V_{CC} = 5 V \pm 0.5 V$		-8		-8	mA	
		V <sub>CC</sub> = 2 V		50		50	μΑ	
loL	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4		4	A	
		$V_{CC} = 5 V \pm 0.5 V$		8		8	mA	
A+/A>.	lanut transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100		100	20/1	
Δt/Δv	Input transition rise or fall rate $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$			20		20	ns/V	
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	V	T <sub>A</sub> = 25°C			SN54AI	HC573	SN74AI	UNIT	
PARAMETER	TEST CONDITIONS	v <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		2 V	1.9	2		1.9		1.9		
	I <sub>OH</sub> = -50 μA	3 V	2.9	3		2.9		2.9		
Voн		4.5 V	4.4	4.5		4.4		4.4		V
	I <sub>OH</sub> = -4 mA	3 V	2.58			2.48		2.48		
	I <sub>OH</sub> = -8 mA	4.5 V	3.94			3.8		3.8		
		2 V			0.1		0.1		0.1	
	Ι <sub>Ο</sub> L = 50 μΑ	3 V			0.1		0.1		0.1	
VOL		4.5 V			0.1		0.1		0.1	V
	I <sub>OL</sub> = 4 mA	3 V			0.36		0.5		0.44	
	I <sub>OL</sub> = 8 mA	4.5 V			0.36		0.5		0.44	
lį	$V_I = V_{CC}$ or GND	0 V to 5.5 V			±0.1		±1*		±1	μΑ
loz	$V_I = V_{IL}$ or $V_{IH}$ , $V_O = V_{CC}$ or GND	5.5 V			±0.25		±2.5		±2.5	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		40		40	μΑ
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		2.5	10				10	pF
Co	$V_O = V_{CC}$ or GND	5 V		3.5					·	pF

 $<sup>^*</sup>$  On products compliant to MIL-PRF-38535, this parameter is not production tested at  $V_{CC} = 0 \text{ V}$ .

## timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

		$T_A = 2$	25°C	SN54AHC573		SN74AHC573		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	ONIT
t <sub>W</sub>	Pulse duration, LE high	5		5		5		ns
t <sub>su</sub>	Setup time, data before LE↓	3.5		3.5		3.5		ns
t <sub>h</sub>	Hold time, data after LE↓	1.5		1.5		1.5		ns

## timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

		$T_A = 2$	25°C	SN54AHC573		SN74AHC573		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	ONIT
t <sub>W</sub>	Pulse duration, LE high	5		5		5		ns
t <sub>su</sub>	Setup time, data before LE↓	3.5		3.5		3.5		ns
th	Hold time, data after LE↓	1.5		1.5		1.5		ns

### SN54AHC573, SN74AHC573 OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

DADAMETER	FROM TO LOAD $T_A = 25^{\circ}C$		;	SN54A	HC573	SN74AI	UNIT				
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
tPLH	D	Q	C 15 pE		7*	11*	1*	13*	1	13	ns
t <sub>PHL</sub>	D	α	C <sub>L</sub> = 15 pF		7*	11*	1*	13*	1	13	115
tPLH	LE	Q	C <sub>L</sub> = 15 pF		7.6*	11.9*	1*	14*	1	14	ns
<sup>t</sup> PHL	LL	Q	GL = 13 pr		7.6*	11.9*	1*	14*	1	14	115
<sup>t</sup> PZH	ŌĒ	Q	C <sub>I</sub> = 15 pF		7.3*	11.5*	1*	13.5*	1	13.5	ns
t <sub>PZL</sub>		Q	CL = 13 pr		7.3*	11.5*	1*	13.5*	1	13.5	115
<sup>t</sup> PHZ	<u></u>	Q	C <sub>L</sub> = 15 pF		8.3*	11*	1*	13*	1	13	ns
tPLZ	ŌE	۷	OL = 13 pi		8.3*	11*	1*	13*	1	13	115
t <sub>PLH</sub>	D	Q	C <sub>L</sub> = 50 pF		9.5	14.5	1	16.5	1	16.5	ns
<sup>t</sup> PHL	D	Q	GL = 30 pr		9.5	14.5	1	16.5	1	16.5	115
t <sub>PLH</sub>	LE	Q	C <sub>L</sub> = 50 pF		10.1	15.4	1	17.5	1	17.5	ns
<sup>t</sup> PHL	LL	Q	CL = 30 pr		10.1	15.4	1	17.5	1	17.5	115
<sup>t</sup> PZH	<del></del>	Q	C <sub>1</sub> = 50 pF		9.8	15	1	17	1	17	ns
t <sub>PZL</sub>	ŌĒ	۷	CL = 30 pi		9.8	15	1	17	1	17	115
t <sub>PHZ</sub>	ŌĒ	Q	C <sub>L</sub> = 50 pF		10.7	14.5	1	16.5	1	16.5	ns
tPLZ	OE	ζ	OL = 30 bi-		10.7	14.5	1	16.5	1	16.5	110
tsk(o)			C <sub>L</sub> = 50 pF			1.5**				1.5	ns

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.
\*\* On products compliant to MIL-PRF-38535, this parameter does not apply.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	λ = 25°C	;	SN54AI	HC573	SN74A	HC573	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	D	Q	C <sub>I</sub> = 15 pF		4.5*	6.8*	1	8*	1	8	ns
<sup>t</sup> PHL	D	Q	CL = 13 μ		4.5*	6.8*	1	8*	1	8	115
<sup>t</sup> PLH	LE	Q	C <sub>L</sub> = 15 pF		5*	7.7*	1	9*	1	9	ns
<sup>t</sup> PHL		α	CL = 15 μr		5*	7.7*	1	9*	1	9	115
<sup>t</sup> PZH	ŌE	Q	C <sub>L</sub> = 15 pF		5.2*	7.7*	1	9*	1	9	ns
<sup>t</sup> PZL	OL	g	OL = 13 pr		5.2*	7.7*	1	9*	1	9	115
<sup>t</sup> PHZ	ŌĒ	Q	C <sub>L</sub> = 15 pF		5.2*	7.7*	1	9*	1	9	ns
t <sub>PLZ</sub>		Q	CL = 13 μ		5.2*	7.7*	1	9*	1	9	115
<sup>t</sup> PLH	D	Q	C <sub>1</sub> = 50 pF		6	8.8	1	10	1	10	ns
<sup>t</sup> PHL	В	3	OL = 30 pi		6	8.8	1	10	1	10	113
<sup>t</sup> PLH	LE	Q	C <sub>L</sub> = 50 pF		6.5	9.7	1	11	1	11	ns
<sup>t</sup> PHL	LL	G G	OL = 30 pi		6.5	9.7	1	11	1	11	113
<sup>t</sup> PZH	<del></del>	Q	C <sub>L</sub> = 50 pF		6.7	9.7	1	11	1	11	ns
tPZL	ŌĒ	3	OL = 30 pi		6.7	9.7	1	11	1	11	113
<sup>t</sup> PHZ	ŌE	Q	C <sub>1</sub> = 50 pF		6.7	9.7	1	11	1	11	ns
<sup>t</sup> PLZ	OE	3	OL = 30 pi		6.7	9.7	1	11	1	11	113
tsk(o)			C <sub>L</sub> = 50 pF			1**				1	ns

On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>\*\*</sup> On products compliant to MIL-PRF-38535, this parameter does not apply.



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### noise characteristics, $V_{CC}$ = 5 V, $C_L$ = 50 pF, $T_A$ = 25°C (see Note 4)

	PARAMETER	SN74AI	HC573	UNIT
	PARAMETER	MIN	MAX	UNIT
VOL(P)	Quiet output, maximum dynamic V <sub>OL</sub>		1	V
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>		-0.8	V
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>	4		V
VIH(D)	High-level dynamic input voltage	3.5		V
V <sub>IL(D)</sub>	Low-level dynamic input voltage		1.5	V

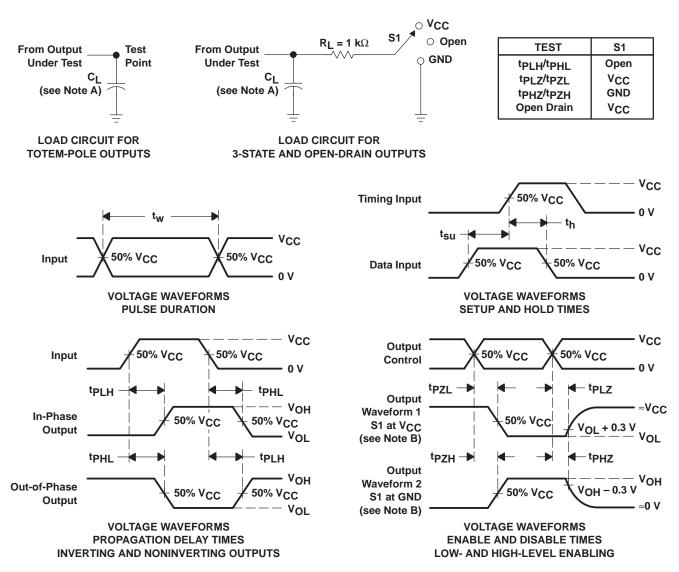
NOTE 4: Characteristics are for surface-mount packages only.

### operating characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CONDITIONS			UNIT
C <sub>pd</sub>	Power dissipation capacitance	No load,	f = 1 MHz	16	pF

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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 3$  ns.  $t_f \leq 3$  ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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